

<b>Notice of References Cited</b>	Application/Control No. 10/588,369		Applicant(s)/Patent Under Reexamination BANIN ET AL.	
	Examiner John P. Dulka		Art Unit 2895	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0175408 A1	11-2002	Majumdar et al.	257/734
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	C	US-			
	D	US-			
	E	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO 03097904 A1	11-2003	World Intellect	BANIN U et al.	
	O	WO 03091458 A1	11-2003	World Intellect	Mayer et al.	
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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